

Notice of References Cited	Application/Control No. 10/537,098	Applicant(s)/Patent Under Reexamination WIENTJENS ET AL.	
	Examiner DAVID H. BANH	Art Unit 4193	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2006/0117972 A1	06-2006	van de Bovenkamp, Antonie Selis	101/216
	B	US-			
	C	US-			
	D	US-			
	E	US-			
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FOREIGN PATENT DOCUMENTS

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